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EXAM INIT.	REF.	PATENT NUMBER					R		ISSUE DATE	PATENTEE	CLASS	SUBCLASS	FILING DATE IF APPRO- PRIATE
17	AA	5	9	4	9	5	5	5	9/7/99	Sakai et al.	358	462	2/3/45
13	AB	5	9	3	6	6	1	6	8/10/99	Torborg, Jr. et al.	345	202	817/46
13	AC	5	9	3	0	4	6	6	7/27/99	Rademacher	395	114	3/11/97
13	AD	5	9	2	3	8	2	0	7/13/99	Cunnagin et al.	395	108	1/23/97
13	AE	5	9	0	7	6	3	8	5/25/99	Onodera	362	239	11/2/97
75	AF	5	8	8	4	0	1	4	3/16/99	Huttenlocher et al.	<del>39</del> 5	114	5/23/96
75	AG	5	5	8	8	1	3	6	12/24/96	Watanabe	395	187	
13	АН	5	4	5	0	5	6	2	9/12/95	Rosenberg et al.	395	446	
TJ	AI	5	3	4	7	6	4	2	9/13/94	Barratt	395	425	
FJ	AJ	4	7	8	3	7	3	5	11/8/88	Miu et al.	364	200	
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<sup>\*</sup> The date should include at least the month and year for a foreign application.

<sup>\*\*</sup>Place of Publication refers to name of publication in which the information being submitted was published.